

## **AUTOMOTIVE GRADE**

# AUIRLR3410

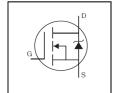
HEXFET® Power MOSFET

### **Features**

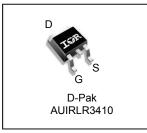
- Advanced Planar Technology
- Low On-Resistance
- · Logic Level Gate Drive
- Dynamic dV/dT Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Repetitive Avalanche Allowed up to Tjmax
- · Lead-Free, RoHS Compliant
- Automotive Qualified \*

# Description

Specifically designed for Automotive applications, this Stripe Planar design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.



V <sub>DSS</sub>	100V
R <sub>DS(on)</sub> max.	105mΩ
I <sub>D</sub>	17A



G	D	S
Gate	Drain	Source

Document number   Dockers Time		Standard Pack		Orderable Part Number	
Base part number	Package Type	Form	Quantity	Orderable Part Number	
ALUDI D2440	D. Dok	Tube	75	AUIRLR3410	
AUIRLR3410	D-Pak	Tape and Reel Left	3000	AUIRLR3410TRL	

### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol Parameter		Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	17	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	12	Α
I <sub>DM</sub>	Pulsed Drain Current ①	60	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	79	W
	Linear Derating Factor	0.53	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 16	V
Single Pulse Avalanche Energy (Thermally Limited) ②⑤		150	mJ
I <sub>AR</sub>	Avalanche Current ①⑤	9.0	А
E <sub>AR</sub>	Repetitive Avalanche Energy ①⑤	7.9	mJ
dv/dt	Pead Diode Recovery dv/dt®	5.0	V/ns
T <sub>J</sub>	Operating Junction and	-55 to + 175	
$T_{STG}$	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

### Thermal Resistance

Symbol	Parameter	Typ	Max.	Units
Syllibol	Farailletei	Тур.	IVIAX.	Ullita
$R_{\theta JC}$	Junction-to-Case ®		1.9	
$R_{\theta JA}$	Junction-to-Ambient ( PCB Mount) ⑦		50	°C/W
$R_{\theta JA}$	Junction-to-Ambient		110	

HEXFET® is a registered trademark of Infineon.

<sup>\*</sup>Qualification standards can be found at www.infineon.com



# Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.122		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
				0.105		V <sub>GS</sub> = 10V, I <sub>D</sub> = 10A ④
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance			0.125	Ω	V <sub>GS</sub> = 5.0V, I <sub>D</sub> = 10A ④
				0.155		V <sub>GS</sub> = 4.0V, I <sub>D</sub> = 9.0A ④
$V_{GS(th)}$	Gate Threshold Voltage	1.0		2.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	7.7			S	$V_{DS} = 25V, I_{D} = 9.0A$ (5)
ı	Drain-to-Source Leakage Current			25	μA	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			250	μΑ	$V_{DS} = 80V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	n 1	V <sub>GS</sub> = 16V
	Gate-to-Source Reverse Leakage			-100	nA	V <sub>GS</sub> = -16V

# Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

-	•	-	-		
$Q_{g}$	Total Gate Charge	 	34		$I_{D} = 9.0A$
$Q_gs$	Gate-to-Source Charge	 	4.8	nC	$V_{DS} = 80V$
$Q_{gd}$	Gate-to-Drain Charge	 	20		V <sub>GS</sub> = 5.0V@\$
$t_{d(on)}$	Turn-On Delay Time	 7.2			$V_{DD} = 50V$
t <sub>r</sub>	Rise Time	 53		no	$I_{D} = 9.0A$
$t_{d(off)}$	Turn-Off Delay Time	 30		ns	$R_G = 6.0\Omega$
t <sub>f</sub>	Fall Time	 26			V <sub>GS</sub> = 5.0V@\$
L <sub>D</sub>	Internal Drain Inductance	 4.5			Between lead, 6mm (0.25in.)
L <sub>S</sub>	Internal Source Inductance	 7.5			from package and center of die contact
C <sub>iss</sub>	Input Capacitance	 800			$V_{GS} = 0V$
Coss	Output Capacitance	 160		pF	V <sub>DS</sub> = 25V
C <sub>rss</sub>	Reverse Transfer Capacitance	 90			f = 1.0MHz©

## **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current (Body Diode)			17		MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①			60		integral reverse p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 9.0A, V_{GS} = 0V $
t <sub>rr</sub>	Reverse Recovery Time		140	210	ns	$T_J = 25^{\circ}C$ , $I_F = 9.0A$
Q <sub>rr</sub>	Reverse Recovery Charge		740	1100	nC	di/dt = 100A/µs⊕⑤
t <sub>on</sub>	Forward Turn-On Time	Intrinsio	turn-or	time is	negligil	ole (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- $^{\circ}$  V<sub>DD</sub> = 25V, starting T<sub>J</sub> = 25°C, L = 3.1mH, R<sub>G</sub> = 25 $\Omega$ , I<sub>AS</sub> = 9.0A, V<sub>GS</sub> =10V. (See fig. 12)
- $\label{eq:local_state} \begin{tabular}{ll} \begin{tabular}{ll} $I_{SD} \leq 9.0A, \ di/dt \leq 540A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ}C. \end{tabular}$
- 4 Pulse width  $\leq 300 \mu s$ ; duty cycle  $\leq 2\%$ .
- ⑤ Uses IRL530N data and test conditions.
- © This is applied for L<sub>S</sub> of D-PAK is measured between lead and center of die contact.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.

 $^{\circ}$  R<sub>0</sub> is measured at T<sub>J</sub> approximately 90°C.



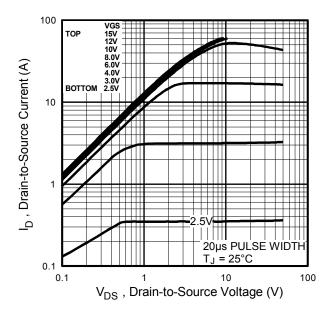
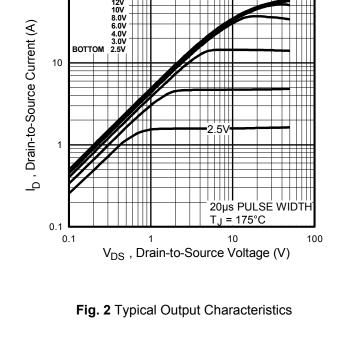


Fig. 1 Typical Output Characteristics



100

TOP

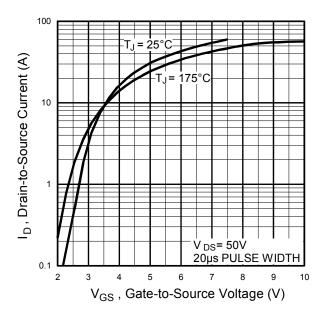
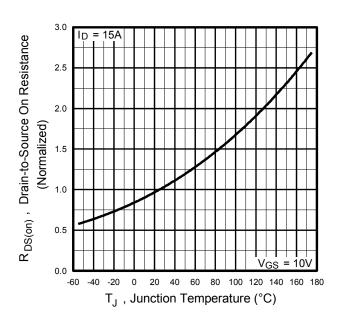
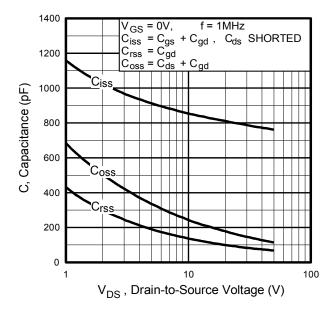


Fig. 3 Typical Transfer Characteristics

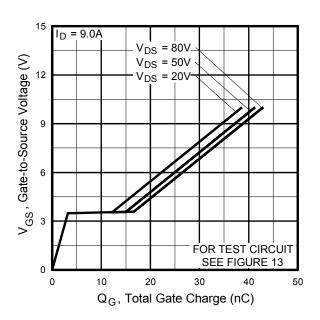


**Fig. 4** Normalized On-Resistance Vs. Temperature





**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage



**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage

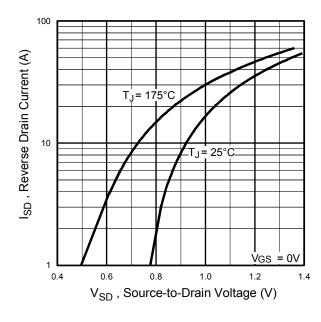


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

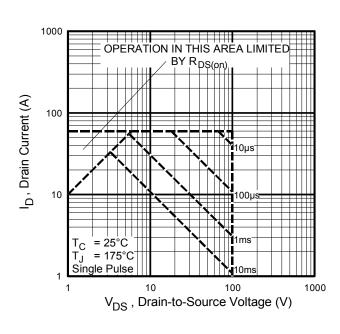
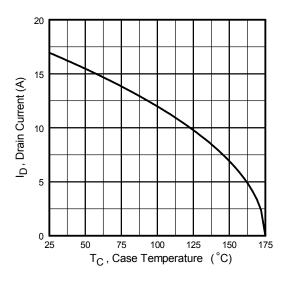


Fig 8. Maximum Safe Operating Area

2015-10-29

4





**Fig 9.** Maximum Drain Current Vs. Case Temperature

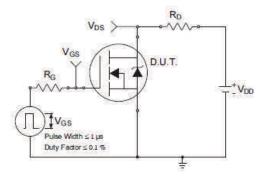


Fig 10a. Switching Time Test Circuit

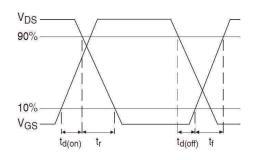


Fig 10b. Switching Time Waveforms

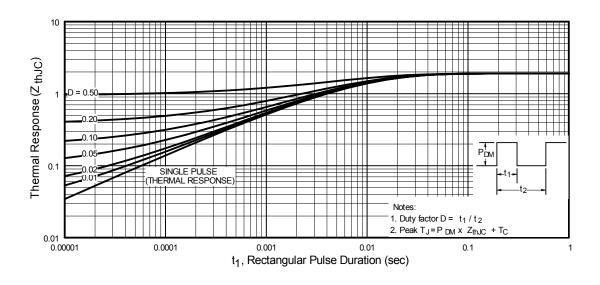


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



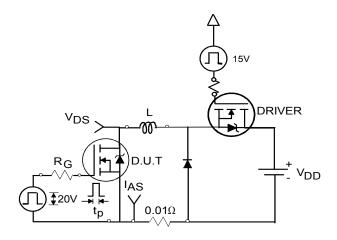


Fig 12a. Unclamped Inductive Test Circuit

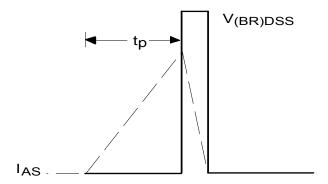


Fig 12b. Unclamped Inductive Waveforms

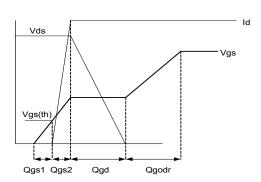
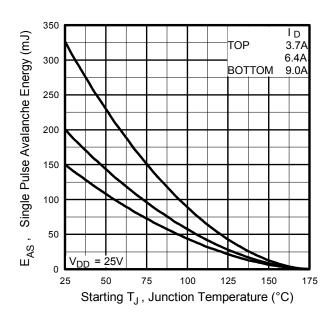


Fig 13a. Gate Charge Waveform



**Fig 12c.** Maximum Avalanche Energy vs. Drain Current

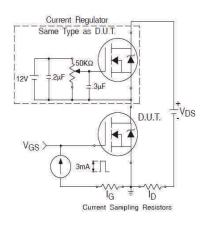
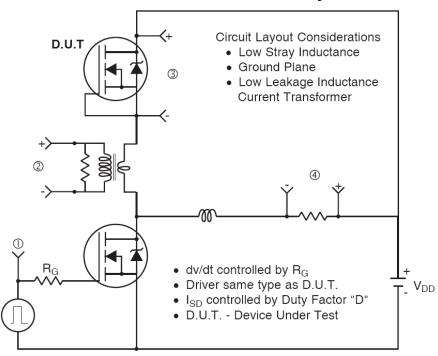


Fig 13b. Gate Charge Test Circuit

2015-10-29



# Peak Diode Recovery dv/dt Test Circuit



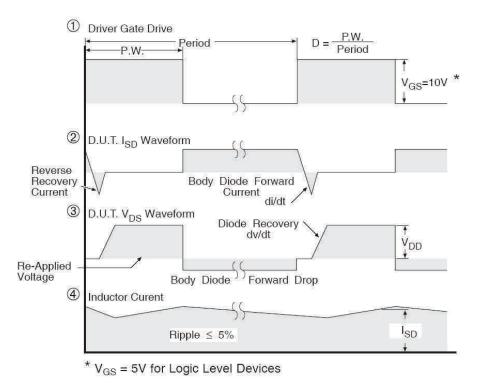
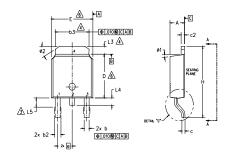


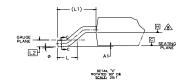
Fig 14. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

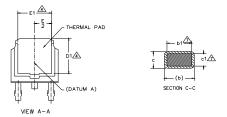


# D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









#### NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- 1 LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.— SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- ⚠ DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.
- ♠ DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

S					N	
Y M	DIMENSIONS					
B	MILLIMETERS INCHES				O T E S	
L	MIN.	MAX.	MIN.	MAX.	S	
Α	2.18	2.39	.086	.094		
A1	-	0.13	-	.005		
b	0.64	0.89	.025	.035		
ь1	0.65	0.79	.025	.031	7	
b2	0.76	1.14	.030	.045		
b3	4.95	5.46	.195	.215	4	
С	0.46	0.61	.018	.024		
c1	0.41	0.56	.016	.022	7	
c2	0.46	0.89	.018	.035		
D	5.97	6.22	.235	.245	6	
D1	5.21	-	.205	-	4	
Ε	6.35	6.73	.250	.265	6	
E1	4.32	-	.170	-	4	
е	2.29	BSC	.090	BSC		
Н	9.40	10.41	.370	.410		
L	1.40	1.78	.055	.070		
L1	2.74	BSC	.108	REF.		
L2	0.51	BSC	.020	BSC		
L3	0.89	1.27	.035	.050	4	
L4	-	1.02	-	.040		
L5	1.14	1.52	.045	.060	3	
ø	0.	10°	0,	10°		
ø1	0,	15*	0,	15*		
ø2	25*	35°	25*	35*		

#### LEAD ASSIGNMENTS

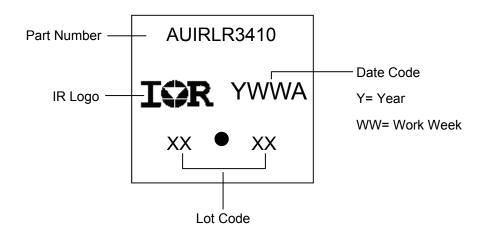
#### **HEXFET**

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

#### IGBT & CoPAK

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER
- 4.- COLLECTOR

## D-Pak (TO-252AA) Part Marking Information

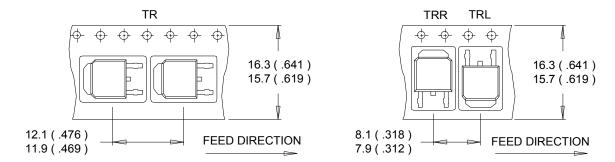


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

2015-10-29

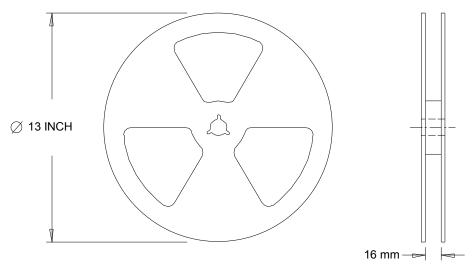


# D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))



### NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



# NOTES:

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>



#### **Qualification Information**

	ion inioniation						
		Automotive					
		(per AEC-Q101)					
Qualificat	tion Level	Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.					
Moisture	Sensitivity Level	MSL1					
	Machine Madel	Class M4 <sup>†</sup>					
	Machine Model	AEC-Q101-002					
FOR	Llucasa Dadu Madal	Class H1C <sup>†</sup>					
ESD	Human Body Model	AEC-Q101-001					
	Ole annual Davide Madal		Class C5 <sup>†</sup>				
Charged Device Model		AEC-Q101-005					
RoHS Co	mpliant	Yes					

† Highest passing voltage.

# **Revision History**

Date	Comments					
3/17/2014	Added "Logic Level Gate Drive" bullet in the features section on page 1.					
3/11/2014	Updated data sheet with new IR corporate template.					
10/29/2015	Updated datasheet with corporate template					
10/29/2015	Corrected ordering table on page 1.					

Published by Infineon Technologies AG 81726 München, Germany © Infineon Technologies AG 2015 All Rights Reserved.

### **IMPORTANT NOTICE**

The information given in this document shall in <u>no event</u> be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie"). With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

For further information on the product, technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies office (<a href="www.infineon.com">www.infineon.com</a>).

## **WARNINGS**

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may <u>not</u> be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.

# **X-ON Electronics**

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET category:

Click to view products by Infineon manufacturer:

Other Similar products are found below:

614233C 648584F IRFD120 JANTX2N5237 FCA20N60\_F109 FDZ595PZ 2SK2545(Q,T) 405094E 423220D TPCC8103,L1Q(CM MIC4420CM-TR VN1206L 614234A 715780A NTNS3166NZT5G SSM6J414TU,LF(T 751625C BUK954R8-60E GROUP A 5962-8877003PA NTE6400 SQJ402EP-T1-GE3 2SK2614(TE16L1,Q) 2N7002KW-FAI DMN1017UCP3-7 EFC2J004NUZTDG ECH8691-TL-W FCAB21350L1 P85W28HP2F-7071 DMN1053UCP4-7 NTE221 NTE222 NTE2384 NTE2903 NTE2941 NTE2945 NTE2946 NTE2960 NTE2967 NTE2969 NTE2976 NTE6400A NTE2910 NTE2916 NTE2956 NTE2956 NTE2911 DMN2080UCB4-7 TK10A80W,S4X(S SSM6P69NU,LF DMP22D4UFO-7B DMN1006UCA6-7